

Notice of References Cited

Application/Control No.

10/003,636

Applicant(s)/Patent Under
Reexamination
CHOUDHURY ET AL.

Examiner

Feben M. Haile

Art Unit

2663

Page 1 of 1

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-------------------|----------------|
| * | A | US-2002/0101826 A1 | 08-2002 | Giacopelli et al. | 370/252 |
| * | B | US-6,529,520 B1 | 03-2003 | Lee et al. | 370/442 |
| * | C | US-6,807,195 B1 | 10-2004 | Moore et al. | 370/503 |
| * | D | US-6,763,032 B1 | 07-2004 | Rabenko et al. | 370/442 |
| | E | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.